

**MFA** **M. Flom Associates, Inc. - Global Compliance Center**  
3356 North San Marcos Place, Suite 107, Chandler, Arizona 85225-7176  
www.mflom.com general@mflom.com (480) 926-3100, FAX: 926-3598

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Date of Report: December 14, 2001  
Date of Submission: January 31, 2002

Federal Communications Commission  
Via Electronic Filing

Attention: Authorization & Evaluation Division

Applicant: Kelvin Hughes Limited  
Equipment: CTX-A9  
FCC ID: CICCTX-A9  
FCC Rules: 80

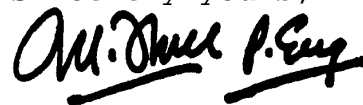
Gentlemen:

On behalf of the Applicant, enclosed please find Application Form 731, Engineering Test Report and all pertinent documentation, the whole for approval of the referenced equipment as shown.

Filing fees are attached.

We trust the same is in order. Should you need any further information, kindly contact the writer who is authorized to act as agent.

Sincerely yours,



Morton Flom, P. Eng.

enclosure(s)  
cc: Applicant  
MF/cvr

LIST OF EXHIBITS  
 (FCC **CERTIFICATION** (TRANSMITTERS) - REVISED 9/28/98)

APPLICANT: Kelvin Hughes Limited

FCC ID: CICCTX-A9

BY APPLICANT:

- 1. LETTER OF AUTHORIZATION x
- 2. IDENTIFICATION DRAWINGS, 2.1033(c)(11)
  - x   LABEL
  - x   LOCATION OF LABEL
  - x   COMPLIANCE STATEMENT
  - x   LOCATION OF COMPLIANCE STATEMENT
- 3. PHOTOGRAPHS, 2.1033(c)(12) x
- 4. DOCUMENTATION: 2.1033(c)
  - (3) INSTALLATION MANUAL x
  - (9) TUNE-UP/ALIGNMENT PROCEDURE x
  - (10) SCHEMATIC DIAGRAM x
  - (10) OPERATIONAL DESCRIPTION x
  - BLOCK DIAGRAM x
  - PARTS LIST x
  - ACTIVE DEVICES x
- 5. PART 80.203(b) ATTESTATION x

BY M.F.A. INC.

- A. TESTIMONIAL & STATEMENT OF CERTIFICATION
- B. STATEMENT OF QUALIFICATIONS



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T R A N S M I T T E R     C E R T I F I C A T I O N

of

FCC ID: CICCTX-A9  
MODEL: CTX-A9

to

FEDERAL COMMUNICATIONS COMMISSION

Rule Part(s) 80

DATE OF REPORT: December 14, 2001

ON THE BEHALF OF THE APPLICANT:

Kelvin Hughes Limited

AT THE REQUEST OF:

P.O. V139928/B5

Kelvin Hughes Limited  
New North Rd.  
Hainault, Ilford  
Essex IG6 2UR, England

Attention of:

David A. Hannah, Chief Engineer  
Dave Everson, Coordinator  
dave.everson@kelvinhughes.co.uk  
Phone: 011 81 500 1020    FAX: 011 44 208 559 8524

SUPERVISED BY:

Morton Flom, P. Eng.

THE APPLICANT HAS BEEN CAUTIONED AS TO THE FOLLOWING:

15.21 INFORMATION TO USER.

The users manual or instruction manual for an intentional radiator shall caution the user that changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

15.27(a) SPECIAL ACCESSORIES.

Equipment marketed to a consumer must be capable of complying with the necessary regulations in the configuration in which the equipment is marketed. Where special accessories, such as shielded cables and/or special connectors are required to enable an unintentional or intentional radiator to comply with the emission limits in this part, the equipment must be marketed with, i.e. shipped and sold with, those special accessories. However, in lieu of shipping or packaging the special accessories with the unintentional or intentional radiator, the responsible party may employ other methods of ensuring that the special accessories are provided to the consumer, without additional charge.


Information detailing any alternative method used to supply the special accessories for a grant of equipment authorization or retained in the verification records, as appropriate. The party responsible for the equipment, as detailed in § 2.909 of this chapter, shall ensure that these special accessories are provided with the equipment. The instruction manual for such devices shall include appropriate instructions on the first page of text concerned with the installation of the device that these special accessories must be used with the device. It is the responsibility of the user to use the needed special accessories supplied with the equipment.

TABLE OF CONTENTS

<u>RULE</u>	<u>DESCRIPTION</u>	<u>PAGE</u>
	Test Report	1
2.1033(c)	General Information Required	2
2.1033(c)(14)	Rule Summary	5
	Standard Test Conditions and Engineering Practices	6
	Summary of Calculations	7
2.1046(a)	Carrier Output Power (Conducted)	10
	Calculation of Peak Power	12
	Detected Pulses	13
2.1047(b)	Modulation Limiting	18
2.1049(c)(1)	Emission Masks (Occupied Bandwidth)	19
2.1051	Unwanted Emissions (Transmitter Conducted)	24
2.1053(a)	Field Strength of Spurious Radiation	25
2.1055(a)(1)	Frequency Stability (Temperature Variation)	29
2.1055(b)(1)	Frequency Stability (Voltage Variation)	31
2.202(g)	Necessary Bandwidth and Emission Bandwidth	32

PAGE NO. 1 of 32.

*Required information per ISO/IEC Guide 25-1990, paragraph 13.2:*

- a) TEST REPORT
- b) Laboratory: M. Flom Associates, Inc.  
 (FCC: 31040/SIT) 3356 N. San Marcos Place, Suite 107  
 (Canada: IC 2044) Chandler, AZ 85225
- c) Report Number: d01c0057
- d) Client: Kelvin Hughes Limited  
 New North Rd.  
 Hainault, Ilford  
 Essex IG6 2UR, England
- e) Identification: CTX-A9  
 FCC ID: CICCTX-A9  
 Description: "S" Band Radar
- f) EUT Condition: Not required unless specified in individual tests.
- g) Report Date: December 14, 2001  
 EUT Received:
- h, j, k): As indicated in individual tests.
- i) Sampling method: No sampling procedure used.
- l) Uncertainty: In accordance with MFA internal quality manual.
- m) Supervised by:   
 Morton Flom, P. Eng.
- n) Results: The results presented in this report relate only to the item tested.
- o) Reproduction: This report must not be reproduced, except in full, without written permission from this laboratory.

PAGE NO. 2 of 32.

LIST OF GENERAL INFORMATION REQUIRED FOR CERTIFICATIONIN ACCORDANCE WITH FCC RULES AND REGULATIONS,  
VOLUME II, PART 2 AND TO

80

Sub-part 2.1033(c)(1): NAME AND ADDRESS OF APPLICANT:Kelvin Hughes Limited  
New North Rd.  
Hainault, Ilford  
Essex IG6 2UR, EnglandMANUFACTURER:

Applicant

(c)(2): FCC ID: CICCTX-A9MODEL NO: CTX-A9(c)(3): INSTRUCTION MANUAL(S):

PLEASE SEE ATTACHED EXHIBITS

(c)(4): TYPE OF EMISSION: 25M8P0N(c)(5): FREQUENCY RANGE, MHz: 3040 to 3060(c)(6): POWER RATING, Watts Peak: 30000  
x Switchable      Variable      N/A(c)(7): MAXIMUM POWER RATING, Watts: 100 Ave.

PAGE NO. 3 of 32.

Subpart 2.1033 (continued)

(c)(8): VOLTAGES & CURRENTS IN ALL ELEMENTS IN FINAL R. F. STAGE, INCLUDING FINAL TRANSISTOR OR SOLID STATE DEVICE:

COLLECTOR CURRENT, A = per manual  
COLLECTOR VOLTAGE, Vdc = per manual  
SUPPLY VOLTAGE, Vac = 110/220, 60 Hz

(c)(9): TUNE-UP PROCEDURE:

PLEASE SEE ATTACHED EXHIBITS

(c)(10): CIRCUIT DIAGRAM/CIRCUIT DESCRIPTION:

Including description of circuitry & devices provided for determining and stabilizing frequency, for suppression of spurious radiation, for limiting modulation and limiting power.

PLEASE SEE ATTACHED EXHIBITS

(c)(11): LABEL INFORMATION:

PLEASE SEE ATTACHED EXHIBITS

(c)(12): PHOTOGRAPHS:

PLEASE SEE ATTACHED EXHIBITS

(c)(13): DIGITAL MODULATION DESCRIPTION:


     ATTACHED EXHIBITS  
  x   N/A

(c)(14): TEST AND MEASUREMENT DATA:

FOLLOWS



M. Flom Associates, Inc. is accredited by the American Association for Laboratory Association (A2LA) as shown in the scope below.



**THE AMERICAN ASSOCIATION FOR LABORATORY ACCREDITATION**

**ACCREDITED LABORATORY**

A2LA has accredited

**M. FLOM ASSOCIATES, INC.**  
Chandler, AZ

for technical competence in the field of

**Electrical (EMC) Testing**


The accreditation covers the specific tests and types of tests listed on the agreed scope of accreditation. This laboratory meets the requirements of ISO/IEC 17025 - 1999 "General Requirements for the Competence of Testing and Calibration Laboratories" and any additional program requirements in the identified field of testing. Testing and calibration laboratories that comply with this International Standard also operate in accordance with ISO 9001 or ISO 9002.

Presented this 2<sup>nd</sup> day of March, 2001.



*Peter Mlynek*  
President  
For the Accreditation Council  
Certificate Number 1008.01  
Valid to December 31, 2002

For tests or types of tests to which this accreditation applies, please refer to the laboratory's Electrical (EMC) Scope of Accreditation



**American Association for Laboratory Accreditation**

SCOPE OF ACCREDITATION TO ISO/IEC 17025-1999

M. FLOM ASSOCIATES, INC.  
Electronic Testing Laboratory  
3356 North San Marcos Place, Suite 107  
Chandler, AZ 85223  
Morton Flom Phone: 480 926 3100

**ELECTRICAL (EMC)**

Valid to: December 31, 2002 Certificate Number: 1008-01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following electromagnetic compatibility tests:

Tests	Standard(s)
RF Emissions	FCC Part 15 (Subparts B and C) using ANSI C63.4-1992; CISPR 11; CISPR 13; CISPR 14; CISPR 22; EN 55011; EN 55013; EN 55014; EN 55022; EN 50081-1; EN 50081-2; ICES-003; AS/NZS 1044; AS/NZS 1053; AS/NZS 3548; AS/NZS 4251.1; CNS 13438
Harmonic Currents	EN 61000-3-2
Fluctuation and Flicker	EN 61000-3-3
RF Immunity	EN: 50082-1, 50082-2 (both excluding "Power Frequency Magnetic Field Immunity" and "Voltage Dips, Short Interruptions, and Line Voltage Variations"); AS/NZS 4251.1
Radiated Susceptibility	EN 61000-4-3; ENV 50140; ENV 50204; IEC 1000-4-3; IEC 801-3
EFT	EN 61000-4-4; IEC 1000-4-4; IEC 801-4
Surge	EN 61000-4-5; ENV 50142; IEC 1000-4-5; IEC 801-5
47 CFR (FCC)	2, 21, 22, 23, 24, 74, 80, 87, 90, 95, 97

*Peter Mlynek*

5301 Buckeystown Pike, Suite 350 • Frederick, MD 21704-8373 • Phone: 301-644 3248 • Fax: 301-662 2974

"This laboratory is accredited by the American Association for Laboratory Accreditation (A2LA) and the results shown in this report have been determined in accordance with the laboratory's terms of accreditation unless stated otherwise in the report."

Should this report contain any data for tests for which we are not accredited, or which have been undertaken by a subcontractor that is not A2LA accredited, such data would not covered by this laboratory's A2LA accreditation.

PAGE NO.

5 of 32.

Sub-part  
2.1033(c)(14):TEST AND MEASUREMENT DATA

All tests and measurement data shown were performed in accordance with FCC Rules and Regulations, Volume II; Part 2, Sub-part J, Sections 2.947, 2.1033(c), 2.1041, 2.1046, 2.1047, 2.1079, 2.1051, 2.1053, 2.1055, 2.1057 and the following individual Parts:

- \_\_\_\_\_ 21 - Domestic Public Fixed Radio Services
- \_\_\_\_\_ 22 - Public Mobile Services
- \_\_\_\_\_ 22 Subpart H - Cellular Radiotelephone Service
- \_\_\_\_\_ 22.901(d) - Alternative technologies and auxiliary services
- \_\_\_\_\_ 23 - International Fixed Public Radiocommunication services
- \_\_\_\_\_ 24 - Personal Communications Services
- \_\_\_\_\_ 74 Subpart H - Low Power Auxiliary Stations
- x \_\_\_\_\_ 80 - Stations in the Maritime Services
- \_\_\_\_\_ 80 Subpart E - General Technical Standards
- \_\_\_\_\_ 80 Subpart F - Equipment Authorization for Compulsory Ships
- \_\_\_\_\_ 80 Subpart K - Private Coast Stations and Marine Utility Stations
- \_\_\_\_\_ 80 Subpart S - Compulsory Radiotelephone Installations for Small Passenger Boats
- \_\_\_\_\_ 80 Subpart T - Radiotelephone Installation Required for Vessels on the Great Lakes
- \_\_\_\_\_ 80 Subpart U - Radiotelephone Installations Required by the Bridge-to-Bridge Act
- \_\_\_\_\_ 80 Subpart V - Emergency Position Indicating Radiobeacons (EPIRB'S)
- \_\_\_\_\_ 80 Subpart W - Global Maritime Distress and Safety System (GMDSS)
- \_\_\_\_\_ 80 Subpart X - Voluntary Radio Installations
- \_\_\_\_\_ 87 - Aviation Services
- \_\_\_\_\_ 90 - Private Land Mobile Radio Services
- \_\_\_\_\_ 94 - Private Operational-Fixed Microwave Service
- \_\_\_\_\_ 95 Subpart A - General Mobile Radio Service (GMRS)
- \_\_\_\_\_ 95 Subpart C - Radio Control (R/C) Radio Service
- \_\_\_\_\_ 95 Subpart D - Citizens Band (CB) Radio Service
- \_\_\_\_\_ 95 Subpart E - Family Radio Service
- \_\_\_\_\_ 95 Subpart F - Interactive Video and Data Service (IVDS)
- \_\_\_\_\_ 97 - Amateur Radio Service
- \_\_\_\_\_ 101 - Fixed Microwave Services

PAGE NO.

6 of 32.

STANDARD TEST CONDITIONS  
and  
ENGINEERING PRACTICES

Except as noted herein, the following conditions and procedures were observed during the testing:

In accordance with ANSI C63.4-1992/2000 Draft, section 6.1.9, and unless otherwise indicated in the specific measurement results, the ambient temperature of the actual EUT was maintained within the range of 10° to 40°C (50° to 104 °F) unless the particular equipment requirements specify testing over a different temperature range. Also, unless otherwise indicated, the humidity levels were in the range of 10% to 90% relative humidity.

Prior to testing, the EUT was tuned up in accordance with the manufacturer's alignment procedures. All external gain controls were maintained at the position of maximum and/or optimum gain throughout the testing.

Measurement results, unless otherwise noted, are worst case measurements.

PAGE NO. 7 of 32.  
NAME OF TEST: Summary of Calculations  
TEST EQUIPMENT: As per attached page

PROCEDURE

Tests and calculations for the indicated parameters were conducted and made as follows:

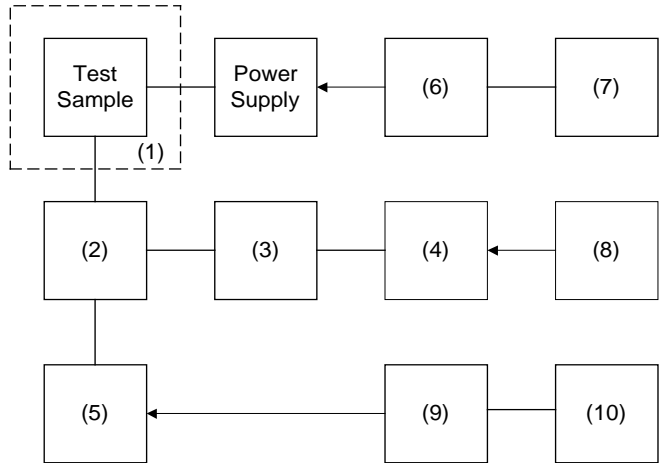
- (1) The average power, pulse widths, pulse rise and decay times, and the interval between successive output pulses were measured.
- (2) The pulse repetition frequency (P.R.F.) was then calculated from the reciprocal of the interval.
- (3) The duty cycle was calculated from the product of the P.F.R. and the pulse width.
- (4) The average power was corrected for attenuation.
- (5) The peak power was calculated by dividing the average power by the duty cycle.
- (6) The spurious and harmonic radiation characteristics, the occupied bandwidth and the receiver radiation were measured.
- (7) MEASUREMENT RESULTS: ATTACHED

PAGE NO.

8 of 32.

TEST SET-UP FOR MEASUREMENT OF:

- |                            |   |
|----------------------------|---|
| TEST A. AVERAGE POWER      | TEST E. SPURIOUS AND HARMONIC EMISSIONS   |
| TEST B. PULSE WIDTHS       | TEST F. FREQUENCY STABILITY               |
| TEST C. PULSE INTERVAL     | TEST G. SPURIOUS RADIATION FIELD STRENGTH |
| TEST D. OCCUPIED BANDWIDTH |   |



Asset Description  
(as applicable)

s/n

- |                                 |                       |              |
|---------------------------------|-----------------------|--------------|
| (1) <u>TEMPERATURE CHAMBER:</u> |                       |              |
| i00027                          | Tenney Temp. Chamber  | 9083-765-234 |
| (2) <u>DIRECTIONAL COUPLER:</u> |                       |              |
| i00187                          | Narda 1080 (S), 40 dB | 50233        |
| i00107                          | Narda 104 (X)         | 890627-001   |
| (3) <u>ADAPTER:</u>             |                       |              |
| i00185                          | HP S281A              | 16           |
| i00188                          | HP X281A              | 17           |
| (4) <u>FREQUENCY METER:</u>     |                       |              |
| i00083                          | HP 536A (S)           | 1441A02335   |
| i00082                          | HP 537A (X)           | 144102889    |
| i00019                          | HP 5334B              | 2704A00347   |
| (5) <u>LOAD TERMINATION:</u>    |                       |              |
| i00186                          | Waveline 281 (S)      | 281          |
| i00189                          | Narda 320B (X)        | 8107         |
| (6) <u>SENSOR:</u>              |                       |              |
| i00016                          | HP 8481A (S,X)        | 1926A25798   |
| i00015                          | HP 8482H (S)          | 1545A00606   |
| (7) <u>POWER METER:</u>         |                       |              |
| i00039                          | HP 436A               | 2709A26776   |
| (8) <u>SPECTRUM ANALYZER:</u>   |                       |              |
| i00048                          | HP 8566B              | 2511A01467   |
| i00029                          | HP 8563E              | 3213A00104   |
| (9) <u>CRYSTAL DETECTOR:</u>    |                       |              |
| i00159                          | HP 8472B              | 1822A10054   |
| (10) <u>OSCILLOSCOPE:</u>       |                       |              |
| i00030                          | HP 54502A             | 2927A00209   |

PAGE NO.

9 of 32.

## MEASUREMENT SUMMARY

Pulse Mode	P.R.F., Hz	Pulse Width, $\mu$ S
Short	3000	0.180
Medium	1500	0.272
Long	750	0.930
Very Long	375	1.082

ITEM	SUMMARY (S-BAND)	SUMMARY (X-BAND)
1. Average Power	Measured with HP 436A with HP 8482H	Measured with HP 436A with HP 8481A
2. Corrected Power	Corrected for Attenuator	
3. P.R.F.	Measured with HP 5334B Frequency Counter	
4. Pulse Width	Measured with HP 54502A Oscilloscope	
5. Peak Power	Calculation: Avg. Power divided by P.R.F. x Pulse Width (duty cycle)	

PAGE NO. 10 of 32.

NAME OF TEST: R.F. Power Output

SPECIFICATION: 47 CFR 2.1046(a), 80.215

GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.1

TEST EQUIPMENT: As per previous page, using:

CMI RCC284-2	HP 436A	HP 8481A(X)
HP S281A, HP X281A	NARDA 320B (X)	HP 8482H(S)
WAVELINE 281 (S)	NARDA 1080 (S)	

MEASUREMENT PROCEDURE

1. The EUT was adjusted in accordance with the manufacturer's tune-up procedure, the test sample and test equipment were set up as shown on the previously attached Test Setup.
2. The power output was measured with an accuracy of  $\pm 3\%$ .
3. MEASUREMENT RESULTS: ATTACHED

PAGE NO. 11 of 32.

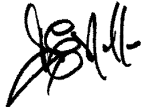
MEASUREMENT RESULTS: R.F. Power (Measured and Calculated)

SAMPLE CALCULATION

Pulse Mode = Short  
 Measured Power,  $\mu$ W = 512  
 Coupler Correction, dB = 40  
 Power Output, Watts, Ave. = 5.12

Pulse Mode	Coupler Attenuation, dB	Corrected Watts, Ave.
Short	40	5.12
Medium	40	8.74
Long	40	11.9
Very Long	40	10.1

PERFORMED BY:

  
 Doug Noble, B.A.S. E.E.T.



PAGE NO. 12 of 32.

NAME OF TEST: Calculation of Peak Power  
TEST EQUIPMENT: N/A

APPLICABLE FORMULAS

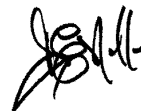
Duty Cycle = P.R.F. x Pulse Width  
 Peak Power =  $\frac{\text{Average Power}}{\text{Duty Cycle}}$

SAMPLE CALCULATION

Pulse Mode = Short  
 Average Power, W (corrected) = 5.12  
 P.R.F., Hz (measured) = 3000  
 Pulse Width,  $\mu\text{s}$  (measured) = 0.180  
 Peak Power, kWP (calculated) = 9.48

CALCULATION SUMMARY

Pulse Mode	Corrected Ave. Power, W	P.R.F., Hz	Pulse Width, $\mu\text{s}$	Peak Power, kW
Short	5.12	3000	0.180	9.48
Medium	8.74	1500	0.2722	21.4
Long	11.9	750	0.930	17.06
Very Long	10.1	375	1.082	24.89



PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

PAGE NO. 13 of 32.

NAME OF TEST: Detected Pulses

TEST EQUIPMENT: As per previous page, using:

HP 54502A

HP 8472B

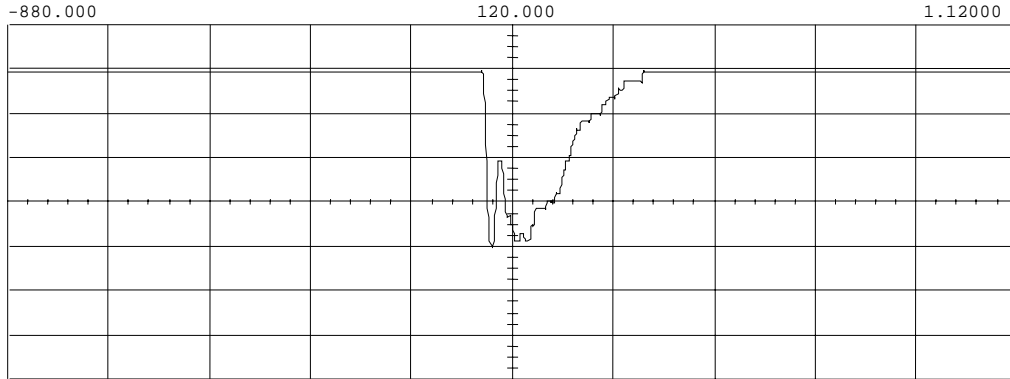
NARDA 4779

MEASUREMENT PROCEDURE

1. In order to determine some of the characteristics of the various pulses, an HP 51502A Oscilloscope Measurement System was connected, through an HP 8472B Detector and a Narda 4779 Attenuator to the Test Setup (previously attached).
2. The detected pulse shapes are shown on the plots following.
3. MEASUREMENT RESULTS: ATTACHED.

PAGE NO. 14 of 32.

NAME OF TEST: Detected Pulses  
g01a0173: 2001-Oct-03 Wed 15:00:00  
STATE: 2:High Power



Main            Timebase            Delay/Pos            Markers  
                  200 ns/div            120.000 ns            delta t = 180.000 ns

Channel 1       Sensitivity       Offset  
                  4.00 mV/div       -12.000 mV

Trigger mode :  
 On Positive Edge Of  
 Trigger  
 - Chan1 = -12.000 mV (noise)  
 Holdoff = -40.000

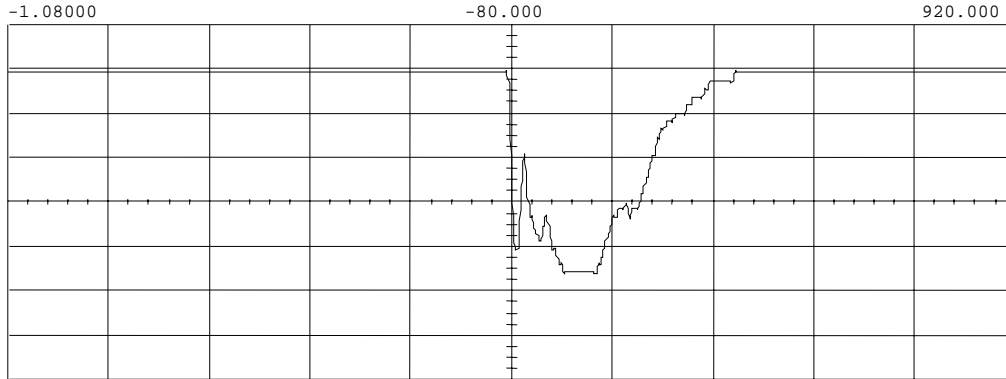
POWER: HIGH  
 MODULATION: SHORT PULSE  
 DESCRIPTION: PULSE = .180 US @ 50% BELOW REFERENCE

PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

PAGE NO. 15 of 32.

NAME OF TEST: Detected Pulses  
g01a0174: 2001-Oct-03 Wed 15:40:00  
STATE: 2:High Power



Main Timebase 200 ns/div Delay/Pos -80.000 ns Markers delta t = 272.000 ns  
 Channel 1 Sensitivity 4.00 mV/div Offset -12.000 mV  
 Trigger mode :  
 On Positive Edge Of  
 Trigger  
 - Chan1 = -12.000 mV (noise)  
 Holdoff = -40.000

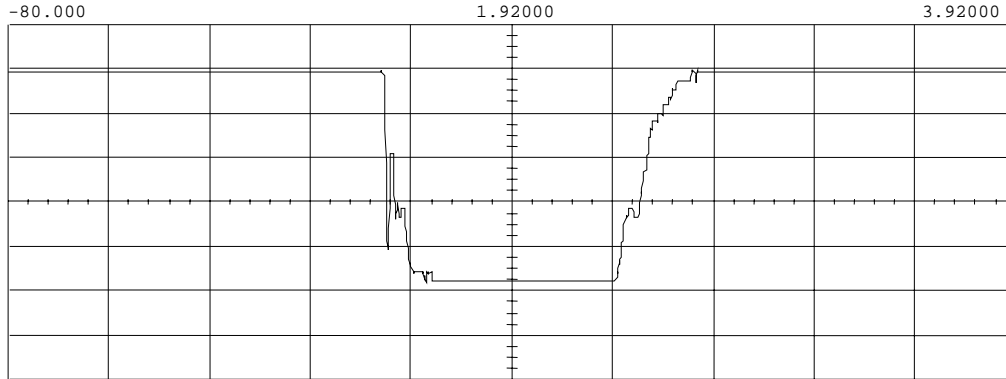
POWER: HIGH  
 MODULATION: MEDIUM PULSE  
 DESCRIPTION: PULSE = .272 US @ 50% BELOW REFERENCE

PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

PAGE NO. 16 of 32.

NAME OF TEST: Detected Pulses  
g01a0175: 2001-Oct-03 Wed 15:50:00  
STATE: 2:High Power



Main Timebase 400 ns/div Delay/Pos 1.92000 us Markers delta t = 930.000 ns  
 Channel 1 Sensitivity 4.00 mV/div Offset -12.000 mV  
 Trigger mode :  
 On Positive Edge Of  
 Trigger  
 - Chan1 = -12.000 mV (noise)  
 Holdoff = -40.000

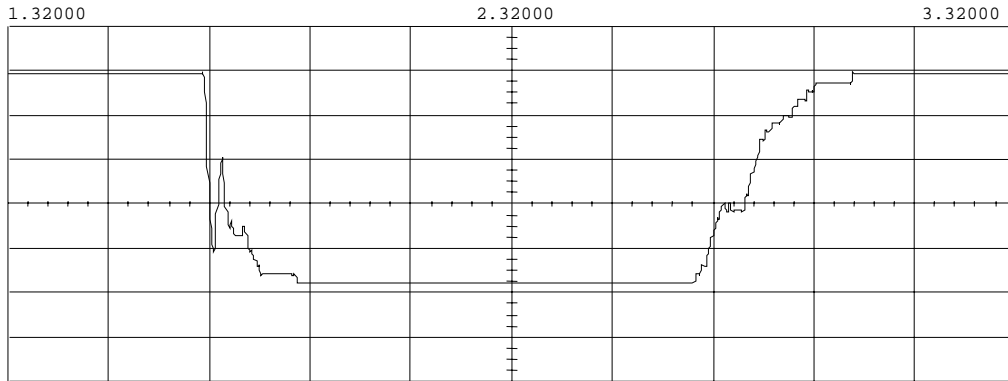
POWER: HIGH  
 MODULATION: LONG PULSE  
 DESCRIPTION: PULSE = .930 US @ 50% BELOW REFERENCE

PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

PAGE NO. 17 of 32.

NAME OF TEST: Detected Pulses  
g01a0176: 2001-Oct-03 Wed 16:06:00  
STATE: 2:High Power



Main Timebase 200 ns/div Delay/Pos 2.32000 us Markers delta t = 1.08200 us  
 Channel 1 Sensitivity 4.00 mV/div Offset -12.000 mV  
 Trigger mode :  
 On Positive Edge Of  
 Trigger  
 - Chan1 = -12.000 mV (noise)  
 Holdoff = -40.000

POWER: HIGH  
 MODULATION: VERY LONG PULSE  
 DESCRIPTION: PULSE = 1.082 US @ 50%  
 BELOW REFERENCE

PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

PAGE NO. 18 of 32.  
NAME OF TEST: Modulation Limiting  
SPECIFICATION: 47 CFR 2.1047(b)  
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph  
TEST EQUIPMENT: N/A

PLEASE SEE TECHNICAL DESCRIPTION, ATTACHED

PAGE NO. 19 of 32.  
NAME OF TEST: Emission Masks (Occupied Bandwidth)  
SPECIFICATION: 47 CFR 2.1049(c)(1), 80.209(b), 80.211  
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.11  
TEST EQUIPMENT: As per previous page, using:  
 CMI RCC284-2 HP 8563E HP 8566B  
 HP 5281A, HP A281A NARDA 320B HP X281A  
 WAVELINE 281 NARDA 1080 NARDA 4779

MEASUREMENT PROCEDURE

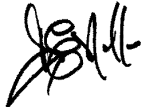
1. The EUT and test equipment were set up as shown on the following page, with the Spectrum Analyzer connected.
2. The digital storage mode of the Spectrum Analyzer does not show internal detail of the pulse. Other analyzer settings were attempted in order to obtain a more "dense" pattern. The one presented here proved to be the optimum.
3. The 99% poewr bandwidth was measured for each pulse mode using HP "Programming note (MAR 1989) for HP 8566B, HP 8568B, Models 218, 226, 236-91".

MEASUREMENT SUMMARY

PULSE MODE	99% POWER BANDWIDTH, MHz
Short	25.8
Medium	25.38
Long	16.23
Very Long	15.50

MEASUREMENT RESULTS: ATTACHED

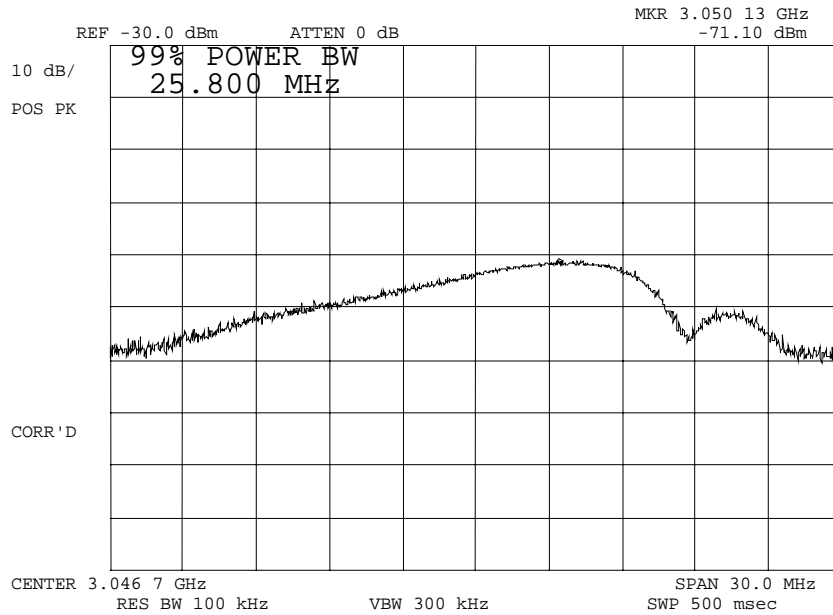
PERFORMED BY:

  
 Doug Noble, B.A.S. E.E.T.



PAGE NO. 20 of 32.

NAME OF TEST: Emission Masks (Occupied Bandwidth)  
g01a0161: 2001-Oct-03 Wed 12:13:00  
STATE: 2:High Power



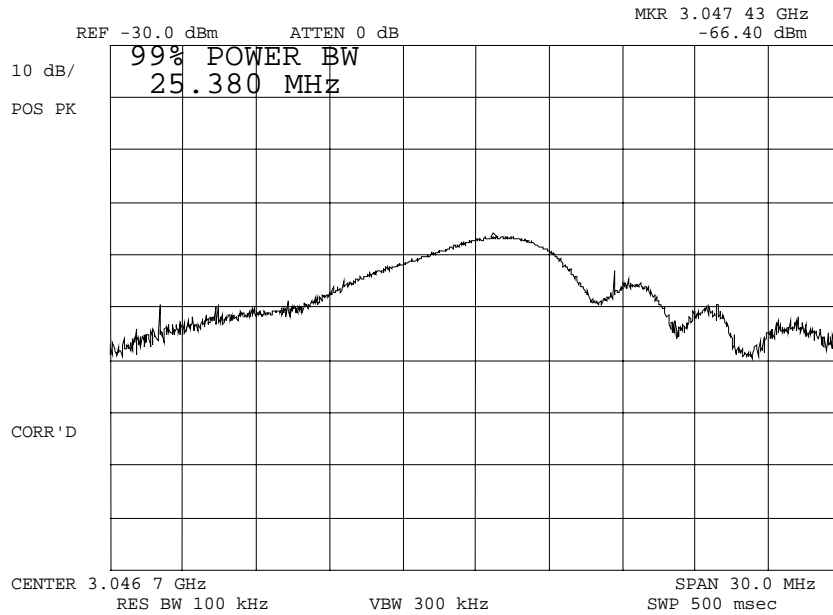
POWER: HIGH  
MODULATION: SHORT PULSE  
99 % POWER BANDWIDTH

PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

PAGE NO. 21 of 32.

NAME OF TEST: Emission Masks (Occupied Bandwidth)  
g01a0162: 2001-Oct-03 Wed 12:16:00  
STATE: 2:High Power



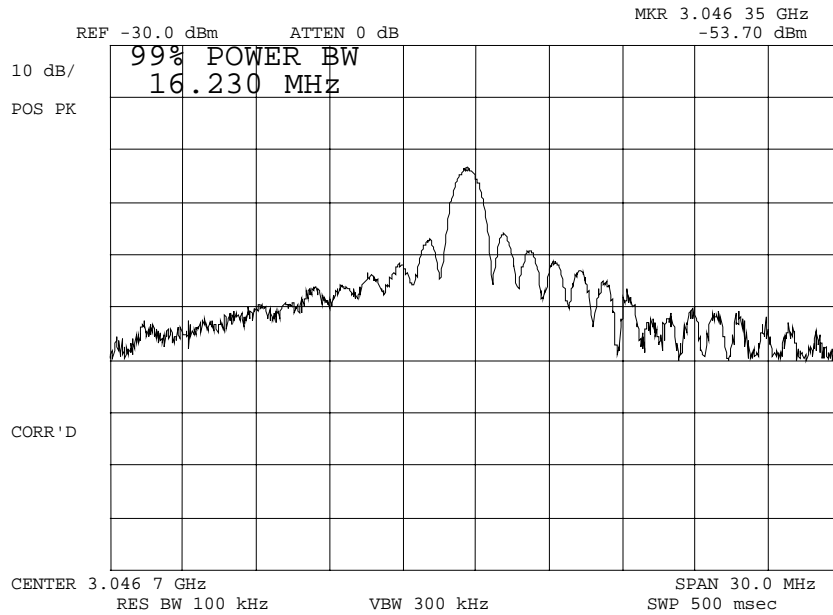
POWER: HIGH  
MODULATION: MEDIUM PULSE  
99 % POWER BANDWIDTH

PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

PAGE NO. 22 of 32.

NAME OF TEST: Emission Masks (Occupied Bandwidth)  
g01a0163: 2001-Oct-03 Wed 12:18:00  
STATE: 2:High Power



POWER: HIGH  
MODULATION: LONG PULSE  
99 % POWER BANDWIDTH

PERFORMED BY:

Doug Noble, B.A.S. E.E.T.



PAGE NO. 24 of 32.

NAME OF TEST: Spurious Emissions at Antenna Terminals (Conducted)

SPECIFICATION: 47 CFR 2.1051, 80.211

GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.13

TEST EQUIPMENT: As per previous page, using:

CMI RCC284-2	HP 8563E	HP S281A
NARDA 320B (X)	HP 8566B	NARDA 1080 / NARDA 104
WAVELINE 281 (S)	NARDA 4779	HP X281A

MEASUREMENT PROCEDURE

1. The test sample was set up as for Occupied Bandwidth.
2. At first, the 0 dB reference level for the main pulse was established
3. The spectrum was searched over the range 0 to 90 GHz, using external mixers on the HP 8566B Spectrum Analyzer.
4. MEASUREMENT RESULTS: ATTACHED

Spectrum Searched, GHZ	= 0 to 90
All Other Emissions	= $\geq 20$ dB below limit
Limit, dBc: $-(43 + 10 \text{ LOG } P_0)$ (Average Power)	= -53.75

Emission, MHz/Harmonic	dbm	Spurious Level, dBc (worst case)
2 x Fc	-21.2	$\leq -62.1$
3 x Fc	-25.3	$\leq -62.1$
4 x Fc	-27.4	$\leq -62.1$
5 x Fc	-28.6	$\leq -62.1$



PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

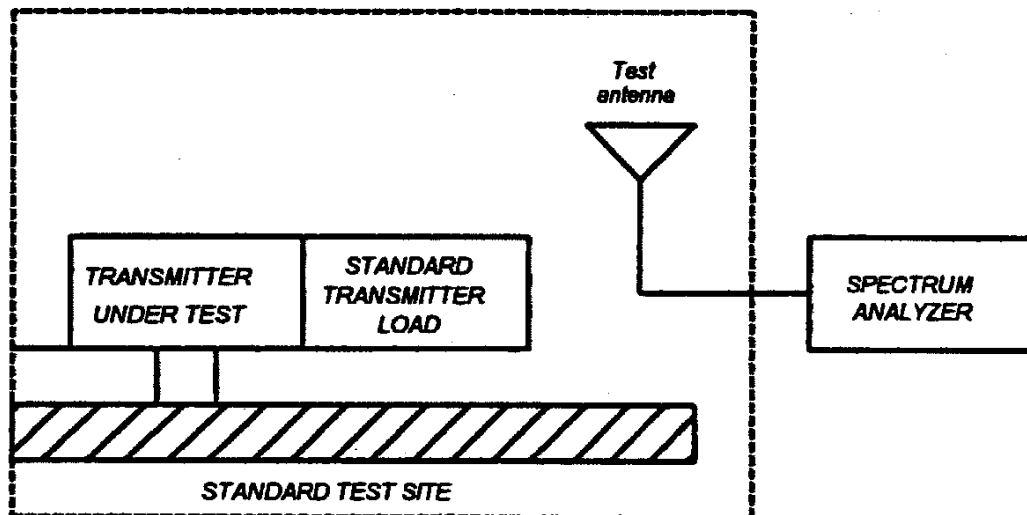
PAGE NO. 25 of 32.  
NAME OF TEST: Field Strength of Spurious Radiation  
SPECIFICATION: 47 CFR 2.1053(a)  
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 1.2.12

MEASUREMENT PROCEDURE

1.2.12.1 Definition: Radiated spurious emissions are emissions from the equipment when transmitting into a non-radiating load on a frequency or frequencies which are outside an occupied band sufficient to ensure transmission of information of required quality for the class of communications desired.

1.2.12.2 Method of Measurement

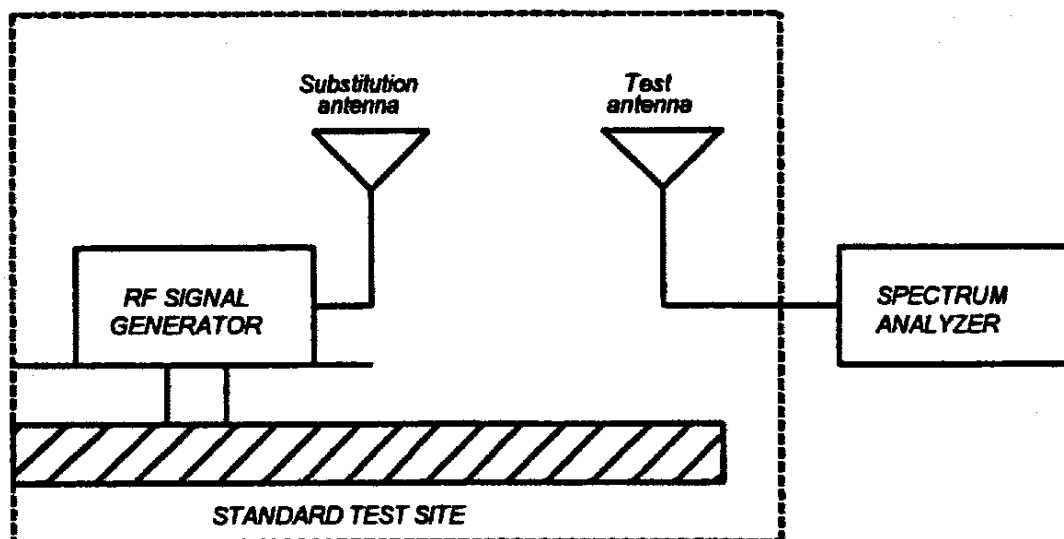
- A) Connect the equipment as illustrated
- B) Adjust the spectrum analyzer for the following settings:
  - 1) Resolution Bandwidth  $\leq 3$  kHz.
  - 2) Video Bandwidth  $\geq 10$  kHz
  - 3) Sweep Speed  $\leq 2000$  Hz/second
  - 4) Detector Mode = Positive Peak
- C) Place the transmitter to be tested on the turntable in the standard test site. The transmitter is transmitting into a non-radiating load which is placed on the turntable. The RF cable to this load should be of minimum length.



PAGE NO. 26 of 32.

NAME OF TEST: Field Strength of Spurious Radiation (Cont.)

- D) For each spurious measurement the test antenna should be adjusted to the correct length for the frequency involved. This length may be determined from a calibration ruler supplied with the equipment. Measurements shall be made from the lowest radio frequency generated in the equipment to the tenth harmonic of the carrier, except for the region close to the carrier equal to  $\pm$  the test bandwidth (see section 1.3.4.4).
- E) For each spurious frequency, raise and lower the test antenna from 1 m to 4 m to obtain a maximum reading on the spectrum analyzer with the test antenna at horizontal polarity. Repeat this procedure to obtain the highest possible reading. Record this maximum reading.
- F) Repeat step E) for each spurious frequency with the test antenna polarized vertically.



- G) Reconnect the equipment as illustrated.
- H) Keep the spectrum analyzer adjusted as in step B).
- I) Remove the transmitter and replace it with a substitution antenna (the antenna should be half-wavelength for each frequency involved). The center of the substitution antenna should be approximately at the same location as the center of the transmitter. At lower frequencies, where the substitution antenna is very long, this will be impossible to achieve when the antenna is polarized vertically. In such case the lower end of the antenna should be 0.3 m above the ground.

PAGE NO. 27 of 32.

NAME OF TEST: Field Strength of Spurious Radiation (Cont.)

- J) Feed the substitution antenna at the transmitter end with a signal generator connected to the antenna by means of a non-radiating cable. With the antennas at both ends horizontally polarized and with the signal generator tuned to a particular spurious frequency, raise and lower the test antenna to obtain a maximum reading at the spectrum analyzer. Adjust the level of the signal generator output until the previously recorded maximum reading for this set of conditions is obtained. This should be done carefully repeating the adjustment of the test antenna and generator output.
- K) Repeat step J) with both antennas vertically polarized for each spurious frequency.
- L) Calculate power in dBm into a reference ideal half-wave dipole antenna by reducing the readings obtained in steps J) and K) by the power loss in the cable between the generator and the antenna and further corrected for the gain of the substitution antenna used relative to an ideal half-wave dipole antenna.
- M) The levels recorded in step L) are absolute levels of radiated spurious emissions in dBm. The radiated spurious emissions in dB can be calculated by the following:

Radiated spurious emissions dB =  
 $10 \log_{10}(\text{TX power in watts}/0.001) - \text{the levels in step l)}$

NOTE: It is permissible that other antennas provided can be referenced to a dipole.

Test Equipment:

Asset	Description	s/n	Cycle	Last Cal
(as applicable)				
<u>TRANSDUCER</u>				
i00088	EMCO 3109-B 25MHz-300MHz	2336	12 mo.	Sep-01
i00065	EMCO 3301-B Active Monopole	2635	12 mo.	Sep-01
i00089	Aprél 2001 200MHz-1GHz	001500	12 mo.	Sep-01
i00103	EMCO 3115 1GHz-18GHz	9208-3925	12 mo.	Sep-01
<u>AMPLIFIER</u>				
i00028	HP 8449A	2749A00121	12 mo.	Mar-01
<u>SPECTRUM ANALYZER</u>				
i00029	HP 8563E	3213A00104	12 mo.	Aug-01
i00033	HP 85462A	3625A00357	12 mo.	May-01
i00048	HP 8566B	2511AD1467	6 mo.	May-01

Per ANSI C63.4-1992/2000 Draft, 10.1.4

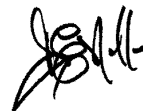


PAGE NO. 28 of 32.

NAME OF TEST: Field Strength of Spurious Radiation

Spectrum Searched, GHZ = 0 to 90  
 All Other Emissions =  $\geq 20$  dB below limit  
 Limit, dBc:  $-(43 + 10 \text{ LOG } P_0)$   
 (Average Power) = -55.3 (16.8 W, Average)  
 Tuned Fc = 3048 MHz

Pulse Mode	Emission MHz	Level $\text{dB}\mu\text{V}/\text{m}$	@ m	C.F., db	Calc $\text{dB}\mu\text{V}/\text{m}$	EIRP dbm	EIRP dbc
Short	2 x Fc	57.5	3	11.2	68.7	$\leq -26.5$	$\leq -63.5$
	3 x Fc	43.5	3	15.3	58.8	$\leq -26.5$	$\leq -63.5$
	4 x Fc	42.3	3	17	59.3	$\leq -26.5$	$\leq -63.5$
	5 x Fc	45.3	3	18.2	63.4	$\leq -26.5$	$\leq -63.5$
Medium	2 x Fc	50.7	3	11.2	61.9	$\leq -25.5$	$\leq -63.5$
	3 x Fc	42.5	3	15.3	57.8	$\leq -25.5$	$\leq -63.5$
	4 x Fc	52.7	3	17	69.7	$\leq -25.5$	$\leq -63.5$
	5 x Fc	51.3	3	18.2	69.4	$\leq -25.5$	$\leq -63.5$
Long	2 x Fc	55	3	11.2	56.2	$\leq -18.9$	$\leq -59.8$
	3 x Fc	59.8	3	15.3	75.1	$\leq -18.9$	$\leq -59.8$
	4 x Fc	59.3	3	17	76.3	$\leq -18.9$	$\leq -59.8$
	5 x Fc	54.2	3	18.2	72.1	$\leq -18.9$	$\leq -59.8$
Very Long	2 x Fc	55.7	3	11.2	66.9	$\leq -18.7$	$\leq -58.7$
	3 x Fc	58.8	3	15.3	74.1	$\leq -18.7$	$\leq -58.7$
	4 x Fc	59.5	3	17	76.5	$\leq -18.7$	$\leq -58.7$
	5 x Fc	53.7	3	18.2	71.8	$\leq -18.7$	$\leq -58.7$



PERFORMED BY:

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PAGE NO. 29 of 32.

NAME OF TEST: Frequency Stability (Temperature Variation)

SPECIFICATION: 47 CFR 2.1055(a)(1)

GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.2

TEST CONDITIONS: As Indicated

TEST EQUIPMENT: As per previous page, using:

CMI RCC284-2		HP 436A
HP 8424H (S)	NARDA 320B (X)	HP 8481A(S,X)
NARDA 1080 (S)	HP S281A (S)	NARDA 320B (X)
WAVELINE 281 (S)	TENNY JR.	

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up in the temperature chamber as shown on the previously attached page.
2. With all power removed, the temperature was decreased to -20°C and permitted to stabilize for three hours. Power was applied and the maximum change in frequency was noted after waiting the period recommended by the manufacturer. Measurement accuracy is ±200 kHz.
3. With power OFF, the temperature was raised in 10°C steps. The sample was permitted to stabilize at each step for at least one-half hour. Power was applied and the maximum frequency change was noted.
4. The temperature tests were performed for the worst case.
5. The frequency tolerance is determined by stabilization of voltages, voltage control feedback circuit, and mechanical tolerances controlled in the manufacture of the magnetron.
5. MEASUREMENT RESULTS: ATTACHED

PAGE NO. 30 of 32.

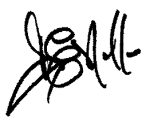
NAME OF TEST: Frequency Stability (Temperature Variation)

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Degrees Celsius	Change in Hz
-20	≤ 520
-10	≤ 520
0	≤ 520
10	≤ 520
20	≤ 520
30	≤ 520
40	≤ 520
50	≤ 520

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PERFORMED BY:

  
Doug Noble, B.A.S. E.E.T.

PAGE NO. 31 of 32.  
NAME OF TEST: Frequency Stability (Voltage Variation)  
SPECIFICATION: 47 CFR 2.1055(b)(1)  
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.2  
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

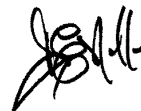
1. The EUT was placed in a temperature chamber at 25±5°C and connected as for "Frequency Stability - Temperature Variation" test.
2. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.
3. The variation in frequency was measured for the worst case.

RESULTS: Frequency Stability (Voltage Variation)

STATE:

LIMIT, ppm =  $3.2 \times 10^{-3}$   
 LIMIT, Hz = 30 MHz

% of STV	VAC	Change, Hz
85	102	0
100	120	0
115	138	0



PERFORMED BY:

Doug Noble, B.A.S. E.E.T.

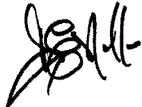
PAGE NO. 32 of 32.  
NAME OF TEST: Necessary Bandwidth and Emission Bandwidth  
SPECIFICATION: 47 CFR 2.202(g)

MODULATION = UNMODULATED PULSE

NECESSARY BANDWIDTH CALCULATION:

RANGE RESOLUTION (r), m	=	4
VELOCITY OF LIGHT (c), m/s	=	$300 \times 10^6$
CONSTANT FACTOR (K)	=	1
NECESSARY BANDWIDTH ( $B_n$ )	=	$(2 \times K) / (2 \times r / c)$
	=	25MO

PERFORMED BY:

  
Doug Noble, B.A.S. E.E.T.

TESTIMONIAL AND STATEMENT OF CERTIFICATION
--

THIS IS TO CERTIFY THAT:

1. THAT the application was prepared either by, or under the direct supervision of, the undersigned.
2. THAT the technical data supplied with the application was taken under my direction and supervision.
3. THAT the data was obtained on representative units, randomly selected.
4. THAT, to the best of my knowledge and belief, the facts set forth in the application and accompanying technical data are true and correct.

CERTIFYING ENGINEER:



Morton Flom, P. Eng.